



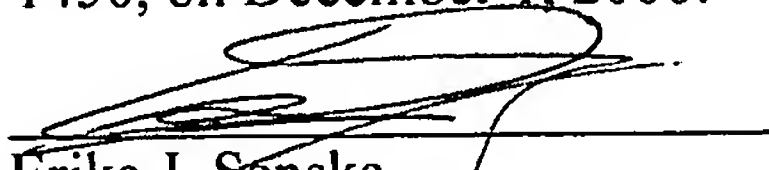
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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Yamakawa, N. Attorney Docket No.: 2352.016
Serial No.: 10/590,122 Group Art Unit: 1632
Filed: August 18, 2006 Examiner: To Be Assigned
Title: DNA ARRAY FOR ANALYZING DNA METHYLATION, METHOD OF
PRODUCING THE SAME AND METHOD OF ANALYZING DNA
METHYLATION

CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the U.S. Postal Service with sufficient postage as first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on December 1, 2006.


Erika J. Senska
Attorney for Applicant
Reg. No. 53,312

Date of Signature: December 1, 2006

To: Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

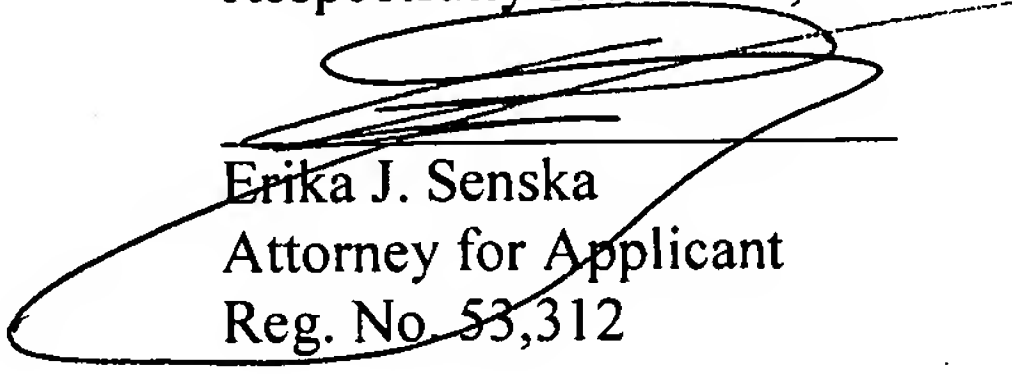
SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Dear Sir:

In accordance with 37 C.F.R. §1.56, Applicant brings to the attention of the Examiner the 1 reference listed on the enclosed Information Disclosure Citation, which is a reference cited in the International Search Report. Please note, the International Search Report incorrectly refers to Toshinori Suzuki as Yoshinori Suzuki, et al. This is a clerical error. An English Translation of the reference is enclosed herewith.

Inasmuch as the present Information Disclosure Statement is being filed before issuance of a first Office Action, it is respectfully submitted that no official surcharge is required.

Respectfully submitted,


Erika J. Senska
Attorney for Applicant
Reg. No. 53,312

Dated: December 1, 2006

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**SUPPLEMENTAL INFORMATION
DISCLOSURE CITATION**

Docket No.: 2352.016

Application No.: 10/590,122

Applicant(s): YAMAKAWA, Naomi

Confirmation No.: 9927

Filing Date: 08/18/2006

GAU: 1632

U.S. PATENT DOCUMENTS

Examiner Initial	Ref	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate

U.S. PATENT APPLICATION PUBLICATIONS

Examiner Initial	Ref	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate

FOREIGN PATENT DOCUMENTS

Examiner Initial	Ref	Document Number	Date	Country	Class	Subclass	Translation		
							Yes	No	Abstract

OTHER DOCUMENTS

Examiner Initial	Ref	(Including Author, Title, Date, Pertinent Pages, etc.)
	DB	Suzuki, et al., Detection of High Methylated Region on Chromosome by Immunofluorescence, The Molecular Biology Society of Japan, Nenka Program Koen Yoshishu, 2002, Vol. 25 th , Page 717.
EXAMINER:		Date Considered:
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.		